

30V N-Ch Power MOSFET

Feature

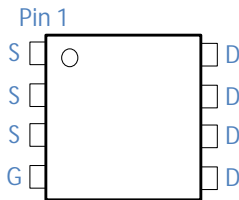
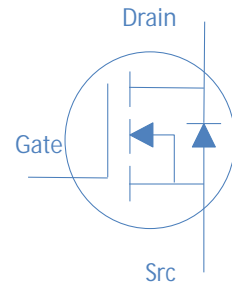
- High Speed Power Switching, Logic Level
- Enhanced Avalanche Ruggedness
- 100% UIS Tested, 100% Rg Tested
- Lead Free, Halogen Free

V_{DS}		30	V
$R_{DS(on),typ}$	$V_{GS}=10V$	1.8	$m\Omega$
I_D (Silicon Limited)		100	A

Application

- Hard Switching and High Speed Circuit
- DC/DC in Telecoms and Industrial

DFN5x6



Part Number	Package	Marking
HTN021N03	DFN5x6	TN021N03

Absolute Maximum Ratings at $T_J=25$ (unless otherwise specified)

Parameter	Symbol	Conditions	Value	Unit
Continuous Drain Current (Silicon Limited)	I_D	$T_C=25$	100	A
		$T_C=100$	75	
Drain to Source Voltage	V_{DS}	-	30	V
Gate to Source Voltage	V_{GS}	-	± 20	V
Pulsed Drain Current	I_{DM}	-	400	A
Avalanche Energy, Single Pulse	E_{AS}	$L=0.1mH, T_C=25$	211	mJ
Power Dissipation	P_D	$T_C=25$	50	W
Operating and Storage Temperature	T_J, T_{stg}	-	-55 to 150	

Absolute Maximum Ratings

Parameter	Symbol	Max	Unit
Thermal Resistance Junction-Ambient	$R_{\theta JA}$	50	$^{\circ}W$
Thermal Resistance Junction-Case	$R_{\theta JC}$	2.5	$^{\circ}W$

Electrical Characteristics at $T_J=25$ (unless otherwise specified)

Static Characteristics

Parameter	Symbol	Conditions	Value			Unit
			min	typ	max	
Drain to Source Breakdown Voltage	$V_{(BR)DSS}$	$V_{GS}=0V, I_D=250\mu A$	30	-	-	V
Gate Threshold Voltage	$V_{GS(th)}$	$V_{GS}=V_{DS}, I_D=250\mu A$	1	1.5	3	
Zero Gate Voltage Drain Current	I_{DSS}	$V_{GS}=0V, V_{DS}=24V, T_J=25$	-	-	1	μA
		$V_{GS}=0V, V_{DS}=20V, T_J=125$	-	-	25	
Gate to Source Leakage Current	I_{GSS}	$V_{GS}=\pm 20V, V_{DS}=0V$	-	-	± 100	nA
Drain to Source on Resistance	$R_{DS(on)}$	$V_{GS}=10V, I_D=25A$	-	1.8	2.1	$m\Omega$
		$V_{GS}=4.5V, I_D=15A$	-	2.7	3.3	
Transconductance	g_{fs}	$V_{DS}=5V, I_D=25A$	-	70	-	S
Gate Resistance	R_G	$V_{GS}=15mV, V_{DS}=0V, f=1MHz$	-	1.5	-	Ω

Dynamic Characteristics

Input Capacitance	C_{iss}		-	3813	-	
Output Capacitance	C_{oss}	$V_{GS}=0V, V_{DS}=15V, f=1MHz$	-	540	-	pF
Reverse Transfer Capacitance	C_{rss}		-	440	-	
Total Gate Charge	$Q_g(10V)$	$V_{DD}=15V, I_D=25A, V_{GS}=10V$	-	59	-	nC
	$Q_g(4.5V)$		-	28	-	
Gate to Source Charge	Q_{gs}		-	13	-	
Gate to Drain (Miller) Charge	Q_{gd}		-	11	-	
Turn on Delay Time	$t_{d(on)}$		-	25	-	
Rise time	t_r	$V_{DD}=15V, I_D=1A, V_{GS}=10V,$	-	16	-	ns
Turn off Delay Time	$t_{d(off)}$	$R_G=2.7\Omega,$	-	60	-	
Fall Time	t_f		-	25	-	

Reverse Diode Characteristics

Diode Forward Voltage	V_{SD}	$V_{GS}=0V, I_F=30A$	-		1.2	V
Reverse Recovery Time	t_{rr}	$I_F=100A, dI_F/dt=100A/\mu s$	-	35	-	ns
Reverse Recovery Charge	Q_{rr}		-	25	-	nC

Fig 1. Typical Output Characteristics

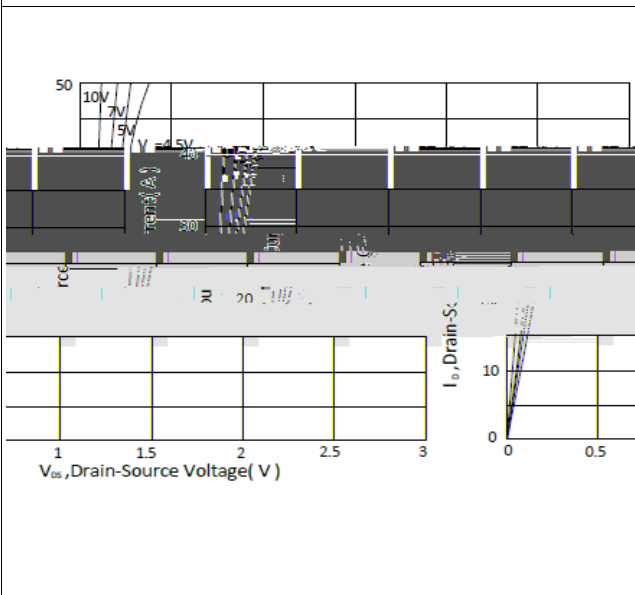


Figure 2. On-Resistance vs. Gate-Source Voltage

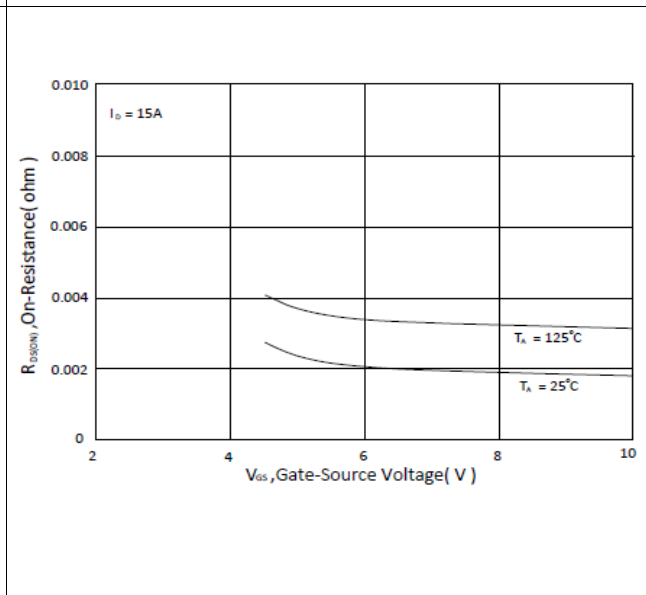


Figure 3. On-Resistance vs. Drain Current and Gate Voltage

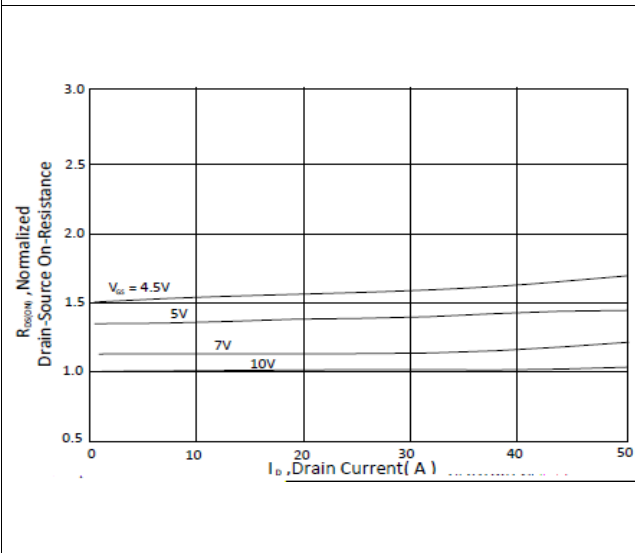


Figure 4. Normalized On-Resistance vs. Junction Temperature

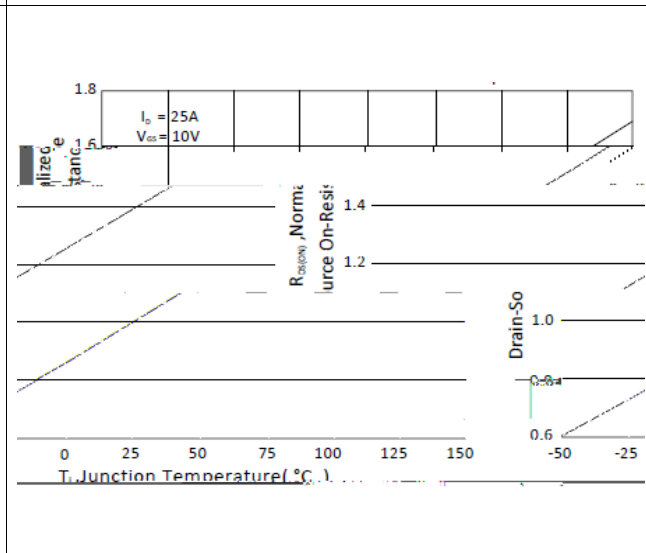


Figure 5. Typical Transfer Characteristics

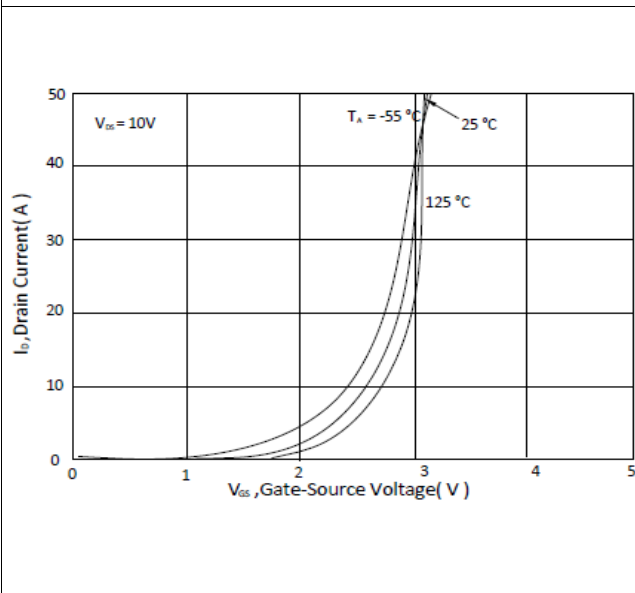


Figure 6. Typical Source-Drain Diode Forward Voltage

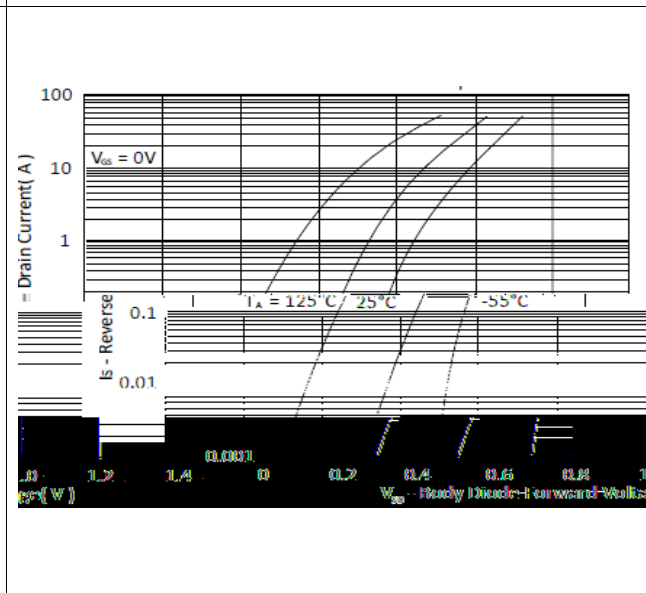


Figure 7. Typical Gate-Charge vs. Gate-to-Source Voltage

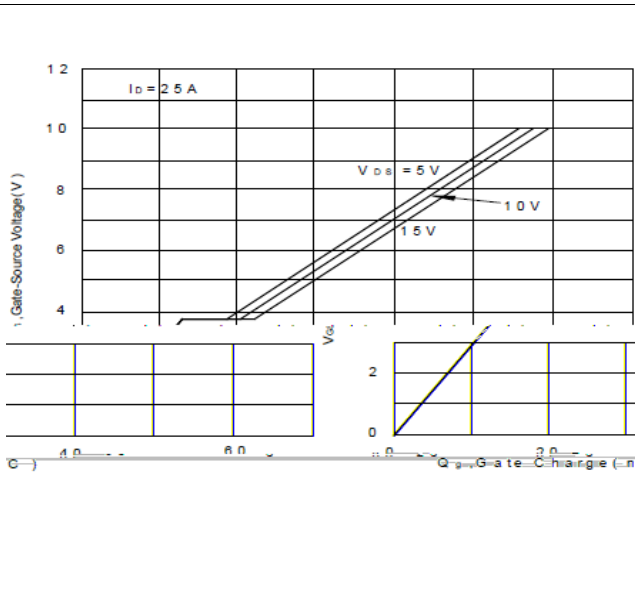


Figure 8. Typical Capacitance vs. Drain-to-Source Voltage

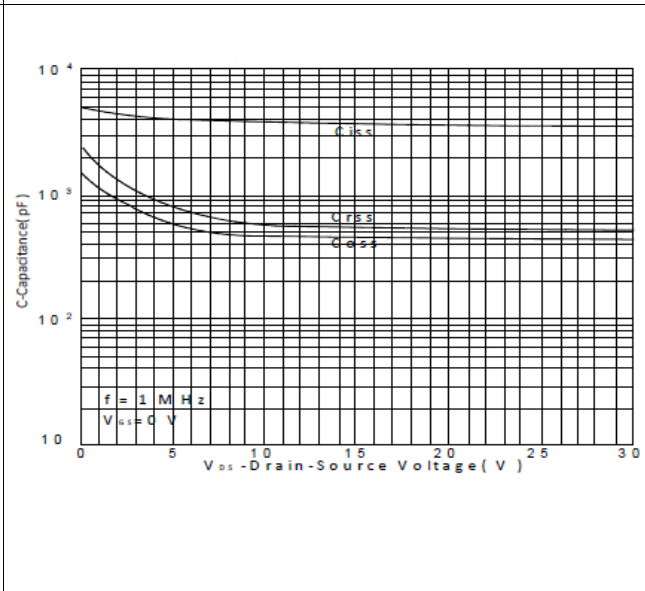


Figure 9. Maximum Safe Operating Area

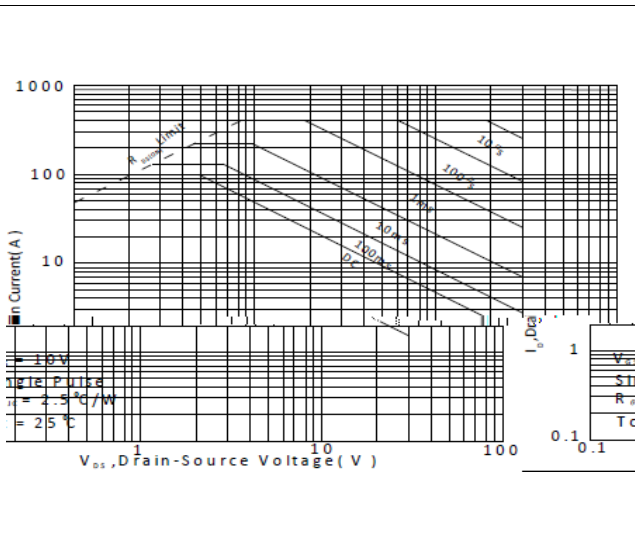


Figure 10. Single Pulse Maximum Power dissipation

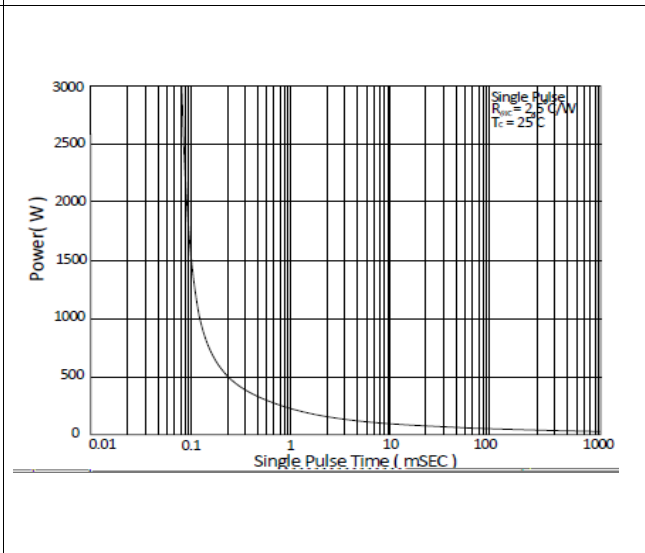
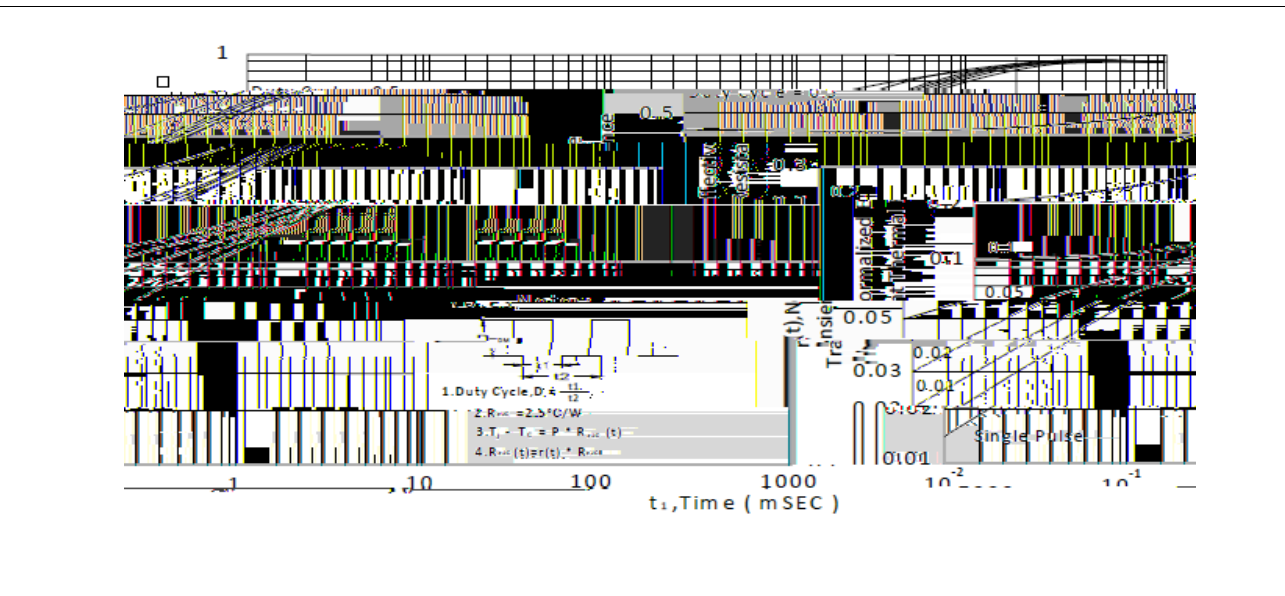


Figure 11. Normalized Maximum Transient Thermal Impedance, Junction-to-Ambient




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Gate Charge Test

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Uclamped Inductive Switching (UIS) Test

	
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Diode Recovery Test

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Outline

DFN5X6_P, 8leads